## Notice of References Cited Application/Control No. 10/528,562 Examiner ABU SHOLEMAN Applicant(s)/Patent Under Reexamination NAKANO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0194475	12-2002	Ishiguro et al.	713/168
*	В	US-6,574,627	06-2003	Bergadano et al.	707/9
*	C	US-6,952,771	10-2005	Zuccherato et al.	713/170
*	D	US-6,952,772	10-2005	Deo et al.	713/170
*	Е	US-7,266,682	09-2007	Euchner, Martin	713/152
*	F	US-6,377,589	04-2002	Knight et al.	370/524
*	G	US-6,697,644	02-2004	Scherzer et al.	455/562.1
*	Η	US-2003/0065918	04-2003	Willey, William Daniel	713/168
*	I	US-7,058,414	06-2006	Rofheart et al.	455/456.4
*	J	US-2002/0012433	01-2002	Haverinen et al.	380/247
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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